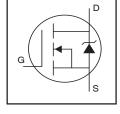
#### **AUTOMOTIVE GRADE**



# AUIRF1404

#### **Features**

- Advanced Planar Technology
- Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified\*



## HEXFET® Power MOSFET

V <sub>(BR)DSS</sub>	40V	
R <sub>DS(on)</sub> typ.	$\mathbf{3.5m}\Omega$	
max	4.0m $Ω$	
I <sub>D (Silicon Limited)</sub>	202A®	
I <sub>D (Package Limited)</sub>	160A	

### **Description**

Specifically designed for Automotive applications, this Stripe Planar design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



G	D	S
Gate	Drain	Source

## **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T<sub>A</sub>) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	202®	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, VGS @ 10V (Silicon Limited)	143	Α
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	160	
I <sub>DM</sub>	Pulsed Drain Current ①	808	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	333	W
	Linear Derating Factor	2.2	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	٧
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) <sup>2</sup>	620	mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig. 12a, 12b, 15, 16	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ①	•	mJ
dv/dt	Peak Diode Recovery dv/dt <sup>③</sup>	1.5	V/ns
$T_{J}$	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

#### **Thermal Resistance**

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ⑦		0.45	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient		62	

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/

## Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.039		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		3.5	4.0	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 121A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Transconductance	76			S	$V_{DS} = 25V, I_D = 121A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 400V, V_{GS} = 0V$
				250		$V_{DS} = 32V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -20V$

## Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$Q_g$	Total Gate Charge		131	196		I <sub>D</sub> = 121A
$Q_{gs}$	Gate-to-Source Charge		36		nC	$V_{DS} = 32V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		37	56		V <sub>GS</sub> = 10V ⊕
t <sub>d(on)</sub>	Turn-On Delay Time		17			$V_{DD} = 20V$
t <sub>r</sub>	Rise Time		190			I <sub>D</sub> = 121A
t <sub>d(off)</sub>	Turn-Off Delay Time		46		ns	$R_G = 2.5 \Omega$
t <sub>f</sub>	Fall Time		33			$R_D = 0.2 \Omega$
L <sub>D</sub>	Internal Drain Inductance		4.5			Between lead,
					nΗ	6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5			from package
						and center of die contact
C <sub>iss</sub>	Input Capacitance		5669			$V_{GS} = 0V$
Coss	Output Capacitance		1659		pF	$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		223			f = 1.0MHz, See Fig. 5
Coss	Output Capacitance		6205			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C <sub>oss</sub>	Output Capacitance		1467			$V_{GS} = 0V, V_{DS} = 32V, f = 1.0MHz$
C <sub>oss</sub> eff.	Effective Output Capacitance (5)		2249		ĺ	$V_{GS} = 0V$ , $V_{DS} = 0V$ to $32V$

#### **Diode Characteristics**

2:040 0:14140:10110						
	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			2026		MOSFET symbol
	(Body Diode)				Α	showing the
I <sub>SM</sub>	Pulsed Source Current			808		integral reverse
	(Body Diode) ①					p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.5	V	$T_J = 25^{\circ}C$ , $I_S = 121A$ , $V_{GS} = 0V$ ④
t <sub>rr</sub>	Reverse Recovery Time		78	117		$T_J = 25^{\circ}C$ , $I_F = 121A$
Q <sub>rr</sub>	Reverse Recovery Charge		163	245	nC	di/dt = 100A/μs <sup>④</sup>
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

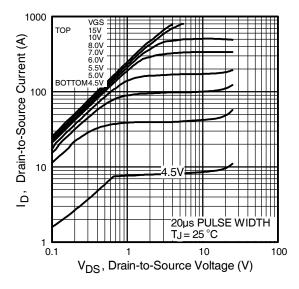
#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- Starting T<sub>J</sub> = 25°C, L = 85μH R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 121A. (See Figure 12)
- 4 Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- $^{\circ}$  C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- © Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 160A.
- $\ensuremath{\mathfrak{T}}$  R  $_\theta$  is measured at T  $_J$  of approximately 90°C.

## Qualification Information<sup>†</sup>

		Automotive (per AEC-Q101) ††			
Qualification Level  Comments: This part number(s) passed Automotiv IR's Industrial and Consumer qualification level extension of the higher Automotive level.			art number(s) passed Automotive qualification. Consumer qualification level is granted by		
Moisture S	Sensitivity Level	TO-220 N/A			
	Machine Model	Class M4 (+/- 425V) <sup>†††</sup> AEC-Q101-002 el Class H2 (+/- 4000V) <sup>†††</sup> AEC-Q101-001			
ESD	Human Body Model				
Charged Device Model		Class C5 (+/- 1125V) <sup>†††</sup> AEC-Q101-005			
RoHS Com	pliant	Yes			

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Exceptions to AEC-Q101 requirements are noted in the qualification report.
- ††† Highest passing voltage.



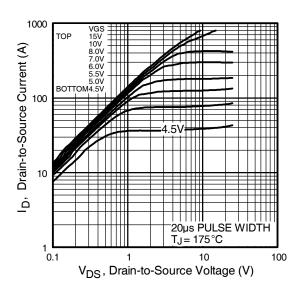
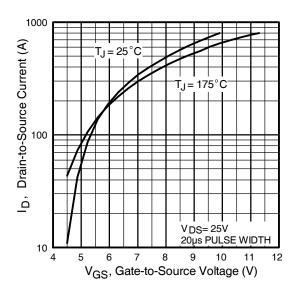


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



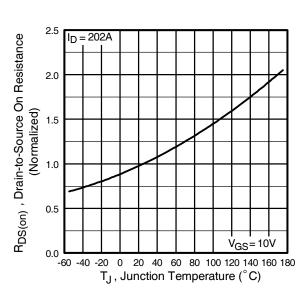
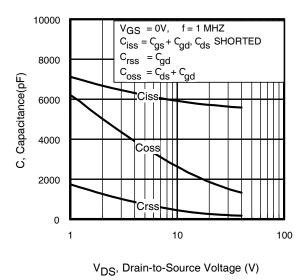
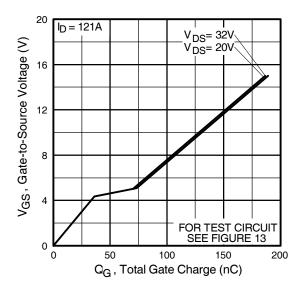


Fig 3. Typical Transfer Characteristics

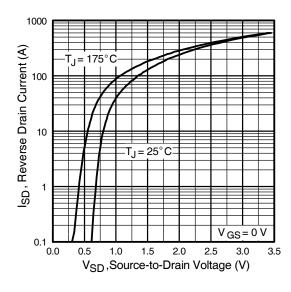
**Fig 4.** Normalized On-Resistance Vs. Temperature

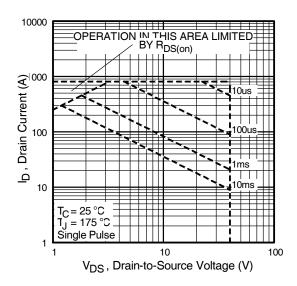




**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

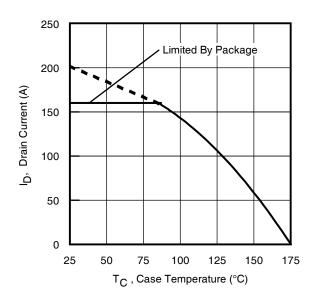
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage





**Fig 7.** Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current Vs. Case Temperature

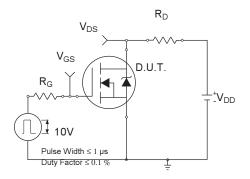


Fig 10a. Switching Time Test Circuit

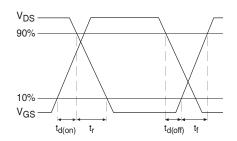


Fig 10b. Switching Time Waveforms

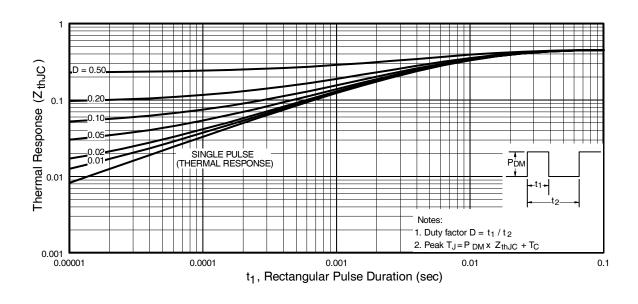


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

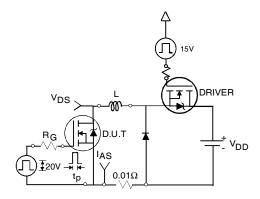


Fig 12a. Unclamped Inductive Test Circuit

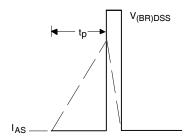


Fig 12b. Unclamped Inductive Waveforms

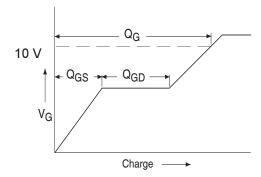


Fig 13a. Basic Gate Charge Waveform

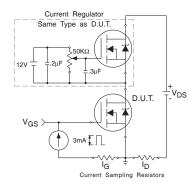


Fig 13b. Gate Charge Test Circuit

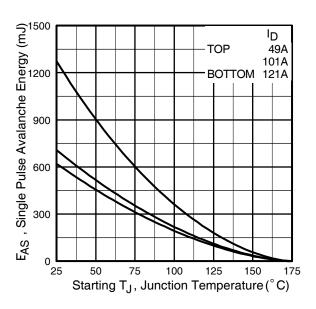


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

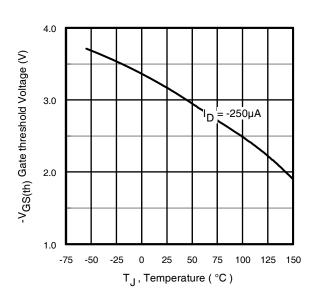


Fig 14. Threshold Voltage Vs. Temperature

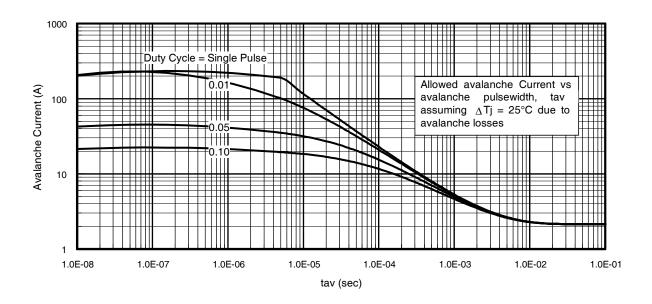
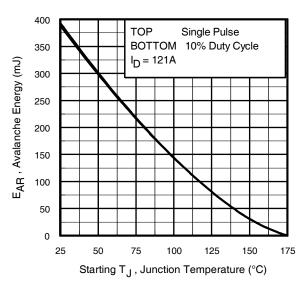


Fig 15. Typical Avalanche Current Vs. Pulsewidth



**Fig 16.** Maximum Avalanche Energy Vs. Temperature

# Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- Safe operation in Avalanche is allowed as long asT<sub>jmax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6.  $I_{av}$  = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{imax}$  (assumed as 25°C in Figure 15, 16).

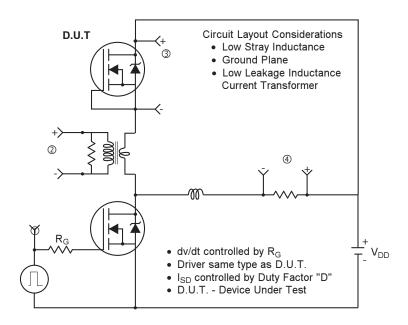
t<sub>av =</sub> Average time in avalanche.

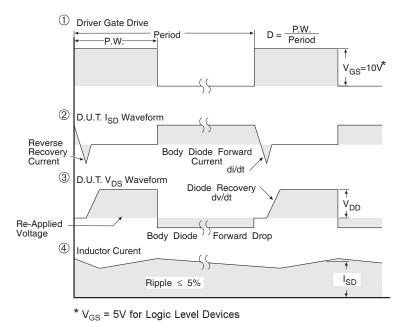
 $D = Duty cycle in avalanche = t_{av} \cdot f$ 

 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{aV}) = \triangle T / \; Z_{thJC} \\ I_{av} &= 2\triangle T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

## Peak Diode Recovery dv/dt Test Circuit



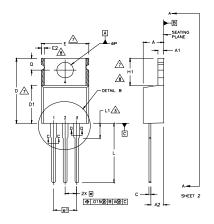


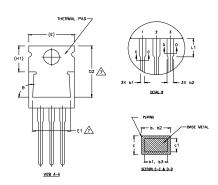
www.irf.com 9

Fig 17. For N-channel HEXFET® Power MOSFETs

## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





#### NOTES

- INMENSIONING AND TOLERANCING PER ASME Y14.5 M— 1994, DMENSIONS ARE SHOWN IN INCHES [MILLIMETERS]. LEAD DMENSION AND FINISH UNCONTROLLED IN L1. DMENSION D. & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. DMENSION 1 M & c1 APPLY TO BASE METAL ONLY. CONTROLLING DIMENSION : INCHES.

  THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1 DMENSION C2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.

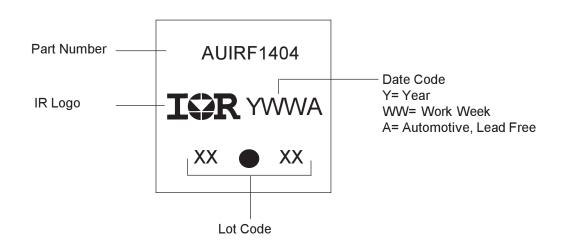
# HEXFET

IGBTs, CoPACK

DIODES

SYMBOL	MILLIM	ETERS	INC	INCHES	
	MIN,	MAX,	MIN.	MAX.	NOTES
Α	3.56	4.82	.140	.190	
A1	0.51	1,40	.020	.055	
A2	2.04	2,92	.080	.115	
b	0.38	1,01	.015	.040	
ь1	0.38	0.96	.015	.038	5
b2	1.15	1.77	.045	.070	
b3	1,15	1,73	.045	.068	
С	0.36	0.61	,014	.024	
c1	0.36	0.56	,014	.022	5
D	14,22	16,51	.560	,650	4
D1	8.38	9.02	.330	.355	
D2	12.19	12.88	.480	.507	7
Ε	9.66	10.66	.380	.420	4,7
E1	8.38	8,89	.330	,350	7
e	2,54	2,54 BSC		,100 BSC	
e1	5.	08	.200 BSC		
H1	5.85	6.55	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	-	6,35	-	,250	3
øΡ	3,54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	
Ø	9093.		90*	-93°	

# TO-220AB Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

## **Ordering Information**

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRF1404	TO-220	Tube	50	AUIRF1404

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